

IN THE SPECIFICATION

Please amend page 10 beginning at line 16 and ending at line 21 as follows:

At the CCDs 1a, 1b, 1c in which stored (accumulated) charges are read out by the frame read-out operation or the field read-out operation in this way, it is possible to perform long time exposure in which each storage time of charges caused to be stored into two-dimensionally arranged photo-diodes is caused to be a value which is a multiple of a natural number of the shortest storage time in respective read-out modes.

Please amend page 11 beginning at line 12 and ending at line 18 as follows:

In the case where long time exposure is performed by the image pick-up apparatus 20 according to the present invention, whether charges are read out by the frame read-out operation which is the first mode or charges are ~~[[raed]]~~ read out by the field read-out operation which is the second mode in accordance with exposure time designated (instructed) from a user is determined by the CPU 9. Thus, read-out control operations of charges corresponding to respective modes are executed by the timing generating circuit 10.